Plasma-assisted and thermal atomic layer deposition of electrochemically active \( \text{Li}_2\text{CO}_3 \)

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Thin-film lithium carbonate (\( \text{Li}_2\text{CO}_3 \)) has applications in various electrochemical devices, like Li-ion batteries, gas sensors and fuel cells. ALD of \( \text{Li}_2\text{CO}_3 \) is of interest for these applications as it allows for uniform and conformal coating of high-aspect ratio structures and particles with very precise thickness control. However, there are few studies that focus on its fabrication and characterization. In this work, plasma-assisted and thermal ALD were adopted to grow ultra-thin, conformal \( \text{Li}_2\text{CO}_3 \) films between 50 and 300 °C using lithium tert-butoxide as a precursor and \( \text{O}_2 \) plasma or \( \text{H}_2\text{O}/\text{CO}_2 \) as co-reactants. More specifically, we focus on the plasma-assisted process by film growth, stability and conductivity studies and emphasize the differences from its more extensively adopted thermal counterpart. Plasma-assisted ALD allows for higher growth per cycle values (0.82 vs. 0.60 Å), lower substrate temperatures and shorter cycle times. The stoichiometry of the films, ranging from \( \text{Li}_2\text{CO}_3 \) to \( \text{Li}_2\text{O} \), can be controlled by substrate temperature and \( \text{O}_2 \) plasma exposure time. The ionic conductivity for both plasma-assisted and thermal ALD is measured for the first time and is in the order of \( 10^{-10} \, \text{S cm}^{-1} \) after normalizing to the different effective surface areas. The Li-ion conductivities found here are in line with literature values predicted by simulation studies.

Introduction

Lithium carbonate is considered a potential electrode passivating film in Li-ion batteries and electrolyte material or sensing layer in electrochemical devices like fuel cells or chemical sensors. This is attributed to its purely ionically conductive behavior and good electrochemical stability. In addition, it is widely used as building block for the fabrication of electrodes and electrolytes or as an additive to improve electrode performance. Despite its widespread usage, there are only few studies in the literature focusing on its characterization.

With the trend of manufacturing devices that have smaller size, weight and lower power consumption, thin film fabrication techniques are becoming preferable. This is especially applicable in the field of Li-ion batteries, where thin-film 3D battery architectures are currently being investigated. Nanostructured energy storage systems have demonstrated a substantial increase in power and energy density. Key to nanostructured energy storage systems is thin films processing of battery active and passive materials compatible with complex battery design. Conventional deposition techniques, such as physical vapor deposition (PVD) and plasma-enhanced chemical vapor deposition (PE-CVD), do not generally lead to conformal thin layers on high aspect ratio structures. To enable fast charging thin-film batteries, conformality and uniform material composition in extreme aspect ratios are required. Therefore, novel deposition techniques leading to enhanced control in thin film properties and conformality are being presently introduced in the field of Li-ion batteries. Atomic layer deposition (ALD), which is based on sequential and self-limiting half-reactions between precursors (co-reactants) and surface, has emerged as a powerful tool since it shows potential towards exceptional conformality on high-aspect ratio structures, thickness control at sub-nanometer level, and tunable film properties. Promising applications of ALD for Li-ion batteries include [surface modification of] particle-based electrodes, 3D-structured electrodes, and 3D all-solid-state microbatteries. Due to the excellent conformity and thickness control of ALD, it is suggested that ALD of lithium carbonate (\( \text{Li}_2\text{CO}_3 \)) is especially beneficial when it is employed as electrode passivating film or as additive to improve electrode performance.

In the present work we focus on the ALD characterization of \( \text{Li}_2\text{CO}_3 \). More specifically, we focus on the plasma-assisted ALD process of \( \text{Li}_2\text{CO}_3 \) by \( \text{(in situ)} \) growth studies and emphasize the differences from its more extensively adopted thermal
counterpart. This is expected to be generally helpful to assess the opportunities of ALD for Li-ion materials. With plasma-assisted ALD a high reactivity is delivered to the deposition surface by the plasma species and therefore less thermal budget is required at the substrate to drive the ALD surface chemistry than for thermal ALD. The application of plasmas in combination with ALD generally leads to a wider range in substrate temperature and processing conditions and thus enables a larger variety of material properties. The process details of ALD Li$_2$CO$_3$ as collected from literature are shown in Table 1. Although the plasma-assisted ALD process for Li$_2$CO$_3$ has already reported in literature, the understanding of the ALD film growth (primarily in terms of developed chemistry during and after deposition) is so far insufficient. In addition, the effect of the process parameters on the layer properties was not reported. To the best of our knowledge we provide the first proper conductivity measurement of thin film Li$_2$CO$_3$.

Moreover, Li$_2$CO$_3$ ALD represents an attractive model process for incorporating Li into multicomponent (ternary) ALD materials, since it is a highly stable compound with respect to process stability and ease of postdeposition analysis of the films. Li$_2$O and LiOH often develop simultaneously during processing due to the reversible reaction with H$_2$O and CO$_2$ and are being deposited by ALD as well. These materials are also widely used as building block for the fabrication of various other Li-ion battery active materials.

### Experimental

All depositions presented in this work were carried out using the thermal and remote plasma ALD reactor FlexAL (Oxford Instruments). The reactor consists of a rotary and turbo molecular pump such that it can reach a base pressure of $<10^{-6}$ Torr by overnight pumping. The pump unit as well as the inductively coupled plasma (ICP) source are connected to the deposition chamber through gate valves.

The ALD processes developed in this work are shown in Fig. 1. For thermal ALD (Fig. 1a), the cycle consists of the exposure of the substrate to LiO’Bu (97%, Sigma Aldrich) lithium precursor, H$_2$O gas and CO$_2$ gas respectively, alternated with argon purges. The plasma-assisted ALD process (Fig. 1b) consists of a combination of the substrate exposure to the same lithium precursor and to an O$_2$-fed plasma with a plasma power of 100 W, alternated by argon purging steps. To ensure the gas flow and pressure have stabilized, the reactor was filled with oxygen prior to switching on the plasma source. Air exposure of the fabricated layers was minimized by transporting the samples in an evacuated transport tube.

The LiO’Bu precursor was bubbled from the precursor pod with Ar at a reactor pressure of 20 mTorr and the precursor and precursor supply line were heated to 140 °C and 150 °C respectively to avoid precursor condensation. The reactor pressure during the O$_2$ plasma generation was 13 mTorr. The process table was heated to 50–300 °C, since it is reported that precursor decomposition takes place from 350 °C. The wafers were placed on an aluminum substrate holder. The reactor wall is maintained at a temperature of 120 °C (which is the maximum wall temperature), except for the deposition at 50 or 100 °C, where the reactor wall is kept at 50 or 100 °C, respectively.

As substrate, 60 nm titanium nitride (TiN) sputtered on silicon was used (Endura PVD). TiN is a barrier for Li-ion diffusion, and also functions as current collector for electrochemical testing of the layers. The film thickness and dielectric function were monitored in situ by spectroscopic ellipsometry (SE) with a J.A. Woollam, Inc. M2000U (0.75–5.0 eV) tool. The dielectric function of Li$_2$CO$_3$ was parameterized using a mathematical description in the form of B-splines, since this method requires no prior knowledge about the dielectric function of the deposited films. Thickness values were confirmed by high resolution SEM (Zeiss Sigma) operated at 2 kV acceleration voltage.

The entire chemical composition of the samples has been characterized with ion beam analysis methods by Detect99. The hydrogen profiles were determined by Elastic Recoil Detection (ERD) using a 1.9 MeV He$^+$ beam impinging on the sample under 15° glancing incidence, and 30° recoil angle. All other elements could be determined in a single run by Elastic Backscattering Spectrometry (EBS) with 2.8 MeV protons at perpendicular incidence. This technique is similar to Rutherford Backscattering Spectrometry (RBS) but has the advantage that the cross sections for light elements is enhanced by the use of high energy protons as projectiles instead of He. Spectra have been registered at 170° and 150° scattering angle. EBS was in this case necessary for the determination of the Li and C contents, for which the sensitivity of RBS is rather poor. Finally, the O, N and Ti contents have been confirmed by channeling RBS using 1900 keV He ions in the same configuration as for the EBS measurements.

X-ray photoelectron spectroscopy (XPS) spectra were recorded using a Thermo Scientific K-alpha+ system using monochromatic Al Kα X-rays. The spot size of the beam was 400 μm and the base pressure of the system was $10^{-8}$ mbar. The depth profile was obtained by an Ar ion gun of 500 eV during 5 s for each sputter step. The crystal structure of the Li$_2$CO$_3$ layers was determined using a Philips X’Pert MPD diffractometer equipped with a Cu Kα source (1.54 Å radiation). The morphology of the deposited layers was investigated by the SEM which was described before.

For electrochemical impedance spectroscopy (EIS) testing an Autolab (Metrohm) potentiostat with a frequency-response analyzer module (frequency range from 0.01 Hz to 1 MHz) was used, operated by Nova software (Metrohm Autolab).

### Table 1

<table>
<thead>
<tr>
<th>Precursor</th>
<th>Co-reactant(s)</th>
<th>$T_{sub}$ (°C)</th>
<th>GPC (Å)</th>
<th>Ref.</th>
</tr>
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<tbody>
<tr>
<td>LiO’Bu</td>
<td>H$_2$O, CO$_2$</td>
<td>225</td>
<td>0.8</td>
<td>16</td>
</tr>
<tr>
<td>LiHMDS</td>
<td>H$_2$O, CO$_2$</td>
<td>89–332</td>
<td>0.41–0.14</td>
<td>17</td>
</tr>
<tr>
<td>LiTMSO</td>
<td>H$_2$O, CO$_2$</td>
<td>200–300</td>
<td>0.5–0.3</td>
<td>18</td>
</tr>
<tr>
<td>LiO’Bu</td>
<td>O$_2$ plasma</td>
<td>225, 300</td>
<td>0.4</td>
<td>19</td>
</tr>
<tr>
<td>Li(thd)</td>
<td>O$_3$</td>
<td>185–225</td>
<td>0.3–0.07</td>
<td>20</td>
</tr>
</tbody>
</table>
three-electrode Teflon cell was clamped on top of the sample using a Kalrez O-ring. A Luggin capillary was used to connect the cell with the reference-electrode compartment. One molar LiClO4 (battery-grade, Sigma-Aldrich) in propylene carbonate was used as the electrolyte. The experiments were carried out in an Ar glovebox (O2, H2O < 1 ppm). Impedance spectroscopy results were analyzed by fitting an equivalent circuit to the data, using MEISP software (Kumho Chemical Laboratories). The obtained fits had a χ² value in the range from 10⁻³ to 10⁻⁵. The relative standard deviation for all fitted values remained below 5%.

Results and discussion

ALD process characterization

A deposition temperature of 150 °C was adopted to investigate the saturation behavior of the surface reactions during the sub-cycles of both thermal and plasma ALD Li2CO3. Film thickness was monitored every 10 cycles by in situ SE measurements while changing precursor or co-reactant dose times. Saturation curves for the thermal ALD process of Li2CO3 are shown in Fig. 2a. A LiO’Bu dose of 6 s, a water dose of 50 ms and a CO2 dose of 2 s were chosen as standard conditions for thermal ALD of Li2CO3. Without H2O dosing no film growth occurred and without CO2, LiOH was formed. Due to a slower response speed of the CO2 valve, dosing of 0.5 s or less did not deliver any CO2 in the chamber (no pressure increase was observed). Purge steps after LiO’Bu and CO2 dose of 2 s are sufficient to remove the reaction products and unreacted species from the processing chamber, although 5 s purge was necessary for H2O. A growth per cycle of 0.60 Å was found for the thermal ALD process.

The saturation behavior of the surface reactions during the two half cycles of the plasma-assisted ALD process, i.e. the exposure to the lithium precursor and O2 plasma, is shown in Fig. 2b: self-limiting growth was verified for both the precursor and the plasma step. For both half-cycles purge steps of 2 s are sufficient to remove the reaction products and unreacted species. A growth per cycle of 0.82 Å was obtained for a deposition temperature of 150 °C.

The previously reported growth per cycle of 0.8 Å for thermal ALD of Li2CO3,16 differs from our values. The reason for this difference is unclear, yet it is noted that the main difference with our process is a higher reactor pressure. Plasma-assisted ALD using LiO’Bu on the other hand was reported to have a growth per cycle of 0.4 Å,19 but the obtained stoichiometry was a mixture of Li2CO3 and Li2O. Our films grown at 150 °C are found to be pure Li2CO3, as shown in the next section. Moreover, no saturation curves were shown in literature to support the data for this particular case. In general, plasma processes...
often have a higher growth per cycle when compared to thermal processes which is in agreement with our results.\textsuperscript{21}

Next, the process window of ALD films was extended to deposition temperatures between 50 and 300 °C. Fig. 3a shows the thickness evolution as a function of the number of ALD cycles for various deposition temperatures. For plasma-assisted ALD and \( T_\text{sub} \leq 200 \) °C, the thickness of the films develops linearly with the number of cycles. For temperatures higher than 250 °C, the film thickness develops according to two slopes, which correlates with a transition in film chemical composition, as discussed in the next section. Due to high temperature sensitivity of the reactions and minor temperature fluctuations of the process table, the trends of the thickness as a function of the number of cycles at 250 °C varied from occasion to occasion: in some cases they tend to be similar to the growth behavior for \( T \approx 200 \) °C and in other instances to \( T > 250 \) °C. Moreover, films deposited at 250 °C showed large height differences (see SEM images in the next section), which complicated the extraction of the film thickness. For the thermal process, no transition in film chemical composition was observed. However, the growth per cycle increases slightly as function of the number of ALD cycles, which can be explained by crystallization of the films (in the ESI† more growth curves are shown for thermal ALD \( \text{Li}_2\text{CO}_3 \)).

In Fig. 3b, both the temperature dependency of the growth per cycle for the plasma-assisted, as well as the thermal ALD process is shown. It can be noticed that the growth per cycle of the thermal ALD process strongly decreases at 50 °C, indicating the lower limit of the temperature window. The ALD process window for the plasma-assisted process is extended towards lower temperatures, as it has a similar growth per cycle at 50 °C as at higher temperatures. The overall growth per cycle is higher for the plasma-assisted process as compared to the thermal process. As mentioned before, this is more often observed for plasma processes due to the relatively high reactivity of the plasma species which could create a higher density of reactive surface sites.\textsuperscript{21} The differences in growth per cycle between thermal and plasma ALD, but also between different deposition temperatures for plasma-assisted ALD are confirmed by EBS data (see Fig. 3b). A slight decrease in growth per cycle with increasing temperature was observed for the thermal ALD process. This decrease might be caused by desorption of part of the absorbed precursor monolayer from the surface, by higher purity film growth or by an increase in film crystallinity. The crystallinity of the films will be further discussed in the next paragraph.

To summarize, it is shown that both plasma-assisted and thermal ALD of \( \text{Li}_2\text{CO}_3 \) show typical ALD growth behavior within a wide temperature window. Plasma-assisted ALD allows for lower temperature depositions, which results in a wider choice of (substrate) materials that can be used. This is particularly useful when temperature-sensitive materials are adopted, such as polymers.\textsuperscript{24} In addition, the plasma-assisted process allows for higher growth per cycle values and shorter cycle times compared to thermal ALD, without compromising on the quality of the layer. This will enable higher throughputs for ALD reactors.

### Chemical composition

The stoichiometry of 50 nm thick films was probed using a combination of ERD and EBS. The atomic percentage of all the elements in the film is reported in Table 2. For thermal and plasma-assisted ALD films grown up to 250 °C, the results point out a stoichiometry very similar to \( \text{Li}_2\text{CO}_3 \). The films are slightly sub-stoichiometric, since the carbon content in the films is relatively low (stoichiometric \( \text{Li}_2\text{CO}_3 \) contains 33.3 at% Li, 16.7 at% C and 50.0 at% O). Furthermore, the calculated mass density for these samples is slightly lower than the bulk density of 2.11 g cm\(^{-3}\). Only a few at% of H is found in the films.

Plasma ALD at 300 °C on the other hand shows a high hydrogen content, suggesting the co-presence of \( \text{LiOH} \). As mentioned before, air exposure of the fabricated layers was minimized by transporting the samples in an evacuated transport tube, although some degradation of the layers cannot be excluded. The hydrogen content is not constant through the film thickness, but is mainly present in the film’s depth indicating air reactivity after deposition (a depth profile shown in
the ESI†). The relatively high carbon content suggests that the film reacted from LiOH towards Li2CO3 upon air exposure. The reactivity of plasma ALD films deposited at 300 °C will be discussed in more detail later in this paragraph.

For all samples, the amount of deposited lithium atoms scales with the growth per cycle obtained by SE (see Fig. 3b). Assuming the mass density of stoichiometric Li2CO3 to be equal to the bulk density of 2.11 g cm−3, one monolayer of lithium carbonate contains roughly 10.58 Li atoms per nm².† Based on the EBS growth per cycle of 2.09 Li atom per nm² for the thermal ALD process, in each cycle approximately 1/5th of a monolayer of Li2CO3 is deposited. For the plasma-assisted process, about 1/4th to 1/3rd of a monolayer is deposited every cycle.

For plasma ALD at 300 °C, the amount of deposited Li atoms deviates strongly from the lower temperature processes. At the same time the SE growth per cycle for this sample, but also for the one prepared at 275 °C, deviates from the lower temperature depositions. The films deposited at higher temperatures changed when they were removed from the reactor as could be observed visually. Furthermore, the ellipsometric data obtained ex situ could not be fitted using the same model as during in situ measurements. The instability, deviating growth per cycle and increased hydrogen content of these layers suggests that the formed layers were not Li2CO3 but rather a mixture of LiOH and Li2O. The increased growth per cycle can be explained by the fact that LiOH is hygroscopic and easily absorbs H2O and forms a hydrate.16,21,28 It is reported for thermal ALD of LiOH at 225 °C that long purge times of 2 hours lead to a stable mass measured by QCM as a result of H2O desorption.44

To further investigate the film instability for growth temperatures above 250 °C, 50 nm thick films were fabricated at different deposition temperatures. These were then subsequently exposed to CO2 and H2O pulses inside the ALD reactor. The films were measured by in situ SE and the phase change (Δ) was monitored at 589 nm after every pulse as shown in Fig. 4. For plasma depositions at 250 °C, Δ was unaffected by CO2 and H2O exposure, pointing out the stability of the film. However, the film deposited at a slightly higher temperature of 275 °C strongly reacted with CO2 whereas for the film deposited at 300 °C Δ only slightly changes during the first pulse. Both LiOH and Li2O could react with CO2 to form Li2CO3. However, it is reported in literature that the reaction between Li2O and CO2

<table>
<thead>
<tr>
<th>Sample</th>
<th>GPC (at. per nm²)</th>
<th>[Li] (at%)</th>
<th>[C] (at%)</th>
<th>[O] (at%)</th>
<th>[H] (at%)</th>
<th>Mass density (g cm⁻³)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Thermal 150 °C</td>
<td>2.09 ± 0.1</td>
<td>33.4 ± 1.7</td>
<td>14.6 ± 0.8</td>
<td>50.7 ± 2.0</td>
<td>1.3 ± 0.2</td>
<td>1.95 ± 0.20</td>
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<tr>
<td>Plasma 150 °C</td>
<td>3.08</td>
<td>32.7</td>
<td>15.1</td>
<td>49.6</td>
<td>2.6</td>
<td>2.06</td>
</tr>
<tr>
<td>Plasma 250 °C</td>
<td>2.76</td>
<td>30.5</td>
<td>15.8</td>
<td>50.9</td>
<td>2.8</td>
<td>1.97</td>
</tr>
<tr>
<td>Plasma 300 °C</td>
<td>6.83</td>
<td>30.9</td>
<td>13.3</td>
<td>44.7</td>
<td>11.1</td>
<td>n.a.</td>
</tr>
</tbody>
</table>

‡ The surface density in atoms per cm² can be calculated via 

\[ \frac{2 \times \rho \times N_A}{\mu}^{\frac{2}{3}} \]

where \( \rho \) is the mass density, \( \mu \) the molecular mass of Li2CO3, and \( N_A \) Avogadro’s number.

For temperatures from 200 to 400 °C only occurs in the top few nanometers of the Li2O and then a self-limiting shell of Li2CO3 develops.29 This in contrast to LiOH, which would be extremely reactive towards CO2. Hence, the film at 300 °C most likely consists of Li2O as after the first CO2 pulse Δ only slightly changes suggesting that only a surface reaction is occurring. During subsequent exposure steps, the layer does not further react with CO2, implying the absence of LiOH. After the CO2 pulses, the sample was subjected to H2O pulses. As observed in Fig. 4, the 300 °C film consisting of Li2O is reacting with the H2O forming LiOH. Next, CO2 is pulsed again, and the layer is again reacting to form Li2CO3. Unlike the film deposited at 300 °C, the as-deposited 275 °C film was very reactive towards the first CO2 pulses and therefore (partly) consisted of LiOH. For all other films, which include plasma ALD films deposited at 50–250 °C and thermal ALD films deposited at 50–300 °C, the change in Δ was negligibly small, indicating that almost no reaction with H2O or CO2 occurred. These stable Li2CO3 films were used for ex situ XPS analysis which will be discussed later in this section.

The in situ SE measurements presented in Fig. 4 show the formation of LiOH/Li2O for plasma-assisted ALD at processing temperatures > 250 °C. For these temperatures it was also

![Fig. 4 Phase shift of the incident light (Δ) from in situ SE measurements of the reaction of CO2 and H2O with ~50 nm plasma ALD films grown at 250, 275 and 300 °C. First, CO2 was dosed into the reaction chamber 20 times with pulses of 2 s, next H2O was pulsed 20 times for 50 ms and afterwards CO2 was again pulsed 20 times. SE data was recorded after every pulse and Δ is plotted at 589 nm.](image-url)
LiOH/Li2O can thus be further stimulated by prolonging the cycle requires a lower number of ALD cycles to become linear, however, for longer plasma exposure times, the growth per cycle for different plasma exposure times is similar. However, for longer plasma exposure times, the growth per cycle requires a lower number of ALD cycles to become linear, compared to shorter plasma exposure times. The formation of LiOH/Li2O can thus be further stimulated by prolonging the plasma exposure time.

The chemical composition of the deposited films was further studied by ex situ XPS. No sputtering procedure was adopted, as it was found that the stoichiometry of the films changed due to interaction with Ar ions. Upon chemical decomposition during sputtering, Li2CO3 experiences a transition to Li2O (ESI†). In Fig. 6, the XPS core level spectra of C 1s, Li 1s and O 1s are shown for thermal ALD at 150 °C. The binding energy scale was calibrated by using the hydrocarbon contamination C 1s peak at 285.0 eV. As expected, the C 1s spectrum shows a main peak at ~290.1 eV assigned to the carbonate environment in Li2CO3. The other peaks fitted with a red line are associated with adventitious carbon on the sample surface. In the Li 1s spectrum a peak at ~55.4 eV is observed which is associated to Li2CO3. The O 1s spectrum consists of a peak with a maximum at ~531.8 eV. The shape of the peak is slightly asymmetric. To visualize the asymmetry a second peak is fitted to the data. The asymmetry can be explained by the crystallographic structure of Li2CO3 in which two oxygen atoms have an identical environment, but the third oxygen has a different environment of surrounding atoms.30 The obtained stoichiometry for this film was: 33.0 at% lithium, 17.7 at% carbon and 49.3 at% oxygen, corresponding to stoichiometric Li2CO3. Proportionate, there is slightly more carbon than obtained by EBS. To some extent, the difference can be explained by the low penetration depth of XPS (~10 nm) and the presence of carbon on the sample surface. All other films (prepared by plasma as well as thermal ALD) are measured and subsequently fitted using the same method and all showed the expected Li2CO3 stoichiometry. The results are summarized in the ESL†.

Li2CO3 films which are only slightly sub-stoichiometric can thus be deposited by thermal as well as by plasma-assisted ALD. In addition, it is possible to deposited Li2O at temperatures > 250 °C using the plasma-assisted process. It has already been shown in literature that this is also possible using thermal ALD for temperatures > 250 °C, when the CO2 step was omitted from the process.39 Deposition of Li2O can be beneficial when presence of carbon in the films is undesirable. On the other hand, with thermal ALD it is possible to deposit Li2CO3 films also at high temperatures of 300 °C. If high temperature Li2CO3 depositions are preferred, for example when the process is combined in super-cycles (to make more complex material structures) employing also precursors or co-reactants which require higher deposition temperatures, the thermal process could be preferred.

Crystallinity and morphology

XRD was used to determine the crystallinity of the films deposited at different temperatures. Fig. 7 shows the X-ray diffractograms for ~50 nm thick films. Both plasma and thermal
ALD films show a typical diffraction peak originating from crystalline Li$_2$CO$_3$. The gonio measurements, which detect periodicity of planes parallel to the surface, show only the peak at 31.7°, meaning the process yields a preferential crystal growth orientation in the <002> direction. For thermal ALD films, the crystallinity increases slightly with increasing deposition temperature. A similar trend was observed in literature for thermal ALD of Li$_2$CO$_3$ on Si (100) substrates using a LiN(SiMe$_3$)$_2$ precursor, although the crystalline growth started only at ~180 °C according to their XRD spectra. The onset for crystalline growth could thus be influenced by the precursor, the substrate or a combination of both.

When considering the plasma ALD Li$_2$CO$_3$ films, the layer deposited at 50 °C is highly crystalline and oriented in the <002> direction, similar to the thermal process. At higher deposition temperatures, the spectra change significantly and the crystallinity seems to be suppressed. Since the samples are measured by gonio XRD, we cannot exclude that there is a crystalline component present in the films because this technique is less sensitive to 50 nm thick films. In Fig. 8, SEM images of the surfaces and cross-sections are shown corresponding to the samples measured by XRD. The film growth, and resulting topography, change drastically when increasing temperature. Although for lower deposition temperatures highly uniform films are formed, at 250 °C, the films show large thickness variations. We expect that this is related to the combustion of organic ligands and the formation of LiOH/Li$_2$O during deposition induced by the O$_2$ plasma.

Conformality

The conformality of the deposition was studied using SEM at different positions on high aspect ratio Si pillars. The pillars, which are 50 μm high and have a diameter of 2 μm, are coated with a ~30 nm TiN current collector using ALD. On top of the TiN a ~50 nm Li$_2$CO$_3$ layer was deposited using a table temperature of 150 °C. Fig. 9 shows 3 SEM pictures taken at different heights along the pillar for plasma-assisted as well as thermal ALD. Image (a) is taken at the top of the pillars and shows a Li$_2$CO$_3$ layer of ~55 nm for the plasma-assisted deposition. Image (b) is taken half way the pillar and depicts a ~45 nm Li$_2$CO$_3$ layer (82% of thickness at top). At the bottom (c), the plasma-assisted Li$_2$CO$_3$ is ~40 nm thick (73%). For thermal ALD on the other hand thicknesses of ~60, 52 (87%) and 48 nm (80%) are measured along the pillars. We can conclude that the conformality on high aspect ratio pillars is rather good. Note that only the lithium exposure time was varied. Elongation of the lithium dosing time drastically improves the conformality of thermal ALD. For example, when thermal ALD was adopted using 6 s lithium dosing instead of 10 s, the Li$_2$CO$_3$ layer at the bottom is 20 nm instead of 48 nm.

Fig. 7 XRD gonio scans of ~50 nm thick Li$_2$CO$_3$ films grown on TiN using thermal (blue) and plasma (red) ALD at different processing temperatures. The bars in the lower panel indicate the expected diffraction from a Li$_2$CO$_3$ powder sample. The reflections at ~42.5° originate from the TiN (200) textured substrate.

Fig. 8 (a) High resolution SEM pictures showing the surface topography and (b) cross-section of Li$_2$CO$_3$ deposited with plasma ALD at 50, 150, and 250 °C. The scale bar applies to all of the pictures.
For plasma ALD the conformality remains similar when varying the lithium dosing time. It is expected that the conformality can still be improved by further optimization of the precursor and plasma exposure steps.

**Electrochemical analysis**

The Li-ion conductivity of plasma and thermal ALD Li2CO3 layers was investigated using impedance spectroscopy. The measurements were performed at open circuit potential (OCP) on 50 nm Li2CO3 films deposited at 150 °C on a TiN current collector. The results are shown in Fig. 10a on a complex plane plot. Both the measured layers show a behavior characteristic of a solid electrolyte: an intercept with the x-axis at high frequency, a semi-circle at medium frequency and a 45° inclined response at low frequency. Such behavior is typically associated with the ionic conductivity through a solid material.

The high frequency intercept with the x-axis is generally attributed to the resistance of the cables, contacts and liquid electrolyte, the semi-circle originates from the ionic conductivity through the solid material and its capacitive response. The 45° slope is typically associated with a Warburg-like response, here the Li-ion diffusion through the liquid electrolyte. Note that in the measurements performed here electronic leakage through the Li2CO3 films is not probed.

Further analysis was performed by fitting an equivalent circuit to the measured impedance response (shown in Fig. 10a). The response of the Li2CO3 layer deposited by thermal ALD could be adequately fitted using model I shown in Fig. 10b which is confirmed by the low χ² value of 5 × 10⁻⁴. When equivalent circuit model II was tried to fit the response of the plasma deposited Li2CO3 layer, no adequate fit could be obtained. For this reason, model II was used, resulting in the fit shown in Fig. 10a. The quality of the fit was again confirmed by the low χ² value of 2 × 10⁻⁴.

From the complex non-linear square fitting of the models to the impedance data, different component values are extracted. The Rs was found to be around 150 Ω for both thermal and plasma samples. This value corresponds to the resistance of the cables and the electrochemical cell. The other relevant parameters are summarized in Table 3. For the thermal sample a resistance (R₁) value of 25 kΩ is extracted, corresponding to a Li-ion conductivity of 4 × 10⁻¹⁰ S cm⁻¹, well in accordance values predicted by simulation studies. From the constant phase element (CPE₁), a capacitance value can be extracted according to the following formula:

\[ C_1 = \frac{1}{\omega R_1} \]

Table 3  Summary of the most relevant circuit model parameters

<table>
<thead>
<tr>
<th>Sample</th>
<th>( R_1 ) (kΩ)</th>
<th>( C_1 ) (F)</th>
<th>( R_2 ) (kΩ)</th>
<th>( C_2 ) (F)</th>
<th>( \chi^2 )</th>
</tr>
</thead>
<tbody>
<tr>
<td>Thermal</td>
<td>25</td>
<td>2 × 10⁻⁷</td>
<td>—</td>
<td>—</td>
<td>5 × 10⁻⁴</td>
</tr>
<tr>
<td>Plasma</td>
<td>2.5</td>
<td>4 × 10⁻⁷</td>
<td>3</td>
<td>8 × 10⁻⁷</td>
<td>2 × 10⁻⁴</td>
</tr>
</tbody>
</table>
Usage of this formula assumes a normal distribution of the time constants associated with the constant phase element. It allows an accurate determination of the capacitance value associated with the CPE even with an \( n \) value around 0.8.35,36 By using the above formalism, a capacitance value of 200 nF is extracted for CPE1, corresponding to a dielectric constant of \( \approx \)25. This value is higher than what is expected for typical oxide films. However, the large surface roughness of the thermal films must be considered (see ES1 Fig. S4f). Such roughness increases the effective contact area of the capacitor which is not included when using the geometrical surface area. For this reason also the extracted ionic conductivity value will be slightly over-estimated and can be adjusted for surface roughness down to a value of \( 10^{-10} \) S cm\(^{-1}\).

The impedance response of the plasma-assisted Li\(_2\)CO\(_3\) sample was also probed. Fig. 10a shows that the plasma sample has a lower ionic resistance (as indicated from the intercept with the x-axis). This semi-circle consists of two overlapping semi-circles with slightly different time constants which is reflected in the model choice (model II). The capacitance values were again extracted by using the previously shown formula. The values found were 400 and 800 nF for respectively CPE1 and CPE2. These values correspond to dielectric constants of 40 and 80, so significantly higher than the one of the thermal sample and too high for typical oxide films.

Such capacity values can be attributed to a change in dielectric constant or different geometrical dimensions. However, no difference in mass density could be detected between the thermal and plasma Li\(_2\)CO\(_3\) layers (see Table 2). Therefore, it is unlikely that a significant difference in dielectric constant exists between the two layers. When considering the morphology of the layers (see Fig. 8), a columnar structure can be seen. Therefore, the liquid electrolyte may contact the individual grains. Clearly this would lead to a significant increase in contact area and thus an increased capacitance value. The distribution in grain size can in such case lead to a distribution in time constants. The two resistance values extracted from the fitting, each correspond to a Li-ion conductivity value in the order of \( 1 \times 10^{-9} \) S cm\(^{-1}\). However, the underestimated of the contact area introduces a significant uncertainty on this value which, based on the increased surface area, will be over-estimated. When normalizing the conductivity value found here to the ratio of the different effective surface areas of the thermal and plasma samples, a conductivity value of \( 10^{-10} \) S cm\(^{-1}\) is obtained, a value again in line with other literature reports.12

**Conclusions**

A comparison has been made between the remote plasma ALD process and its more extensively adopted thermal counterpart. Self-limiting growth was obtained for both processes within a wide temperature window. This wide temperature window could especially useful when Li\(_2\)CO\(_3\) is combined in super-cycles to obtain more complex material stoichiometries, since many other precursors or co-reactants have a limited temperature window. Especially the use of plasma allows for the possibility to deposit at lower process temperatures, which would be beneficial for temperature-sensitive substrates. Moreover, plasma-assisted ALD allows for shorter deposition times and higher growth per cycle values leading to an increase in reactor throughput.

Stoichiometric Li\(_2\)CO\(_3\) films can be deposited with both ALD processes. In addition, it is possible to deposited Li\(_2\)O at temperatures \( >250 \) °C through combustion of the organic ligands. This could be beneficial when presence of carbon in the films is undesirable. For thermal ALD it is necessary to also omit the CO\(_2\) step from the process to obtain Li\(_2\)O. For plasma-assisted ALD, introduction of Li\(_2\)O in the films is accompanied with suppression of film crystallinity and increases film non-uniformity. The formation of Li\(_2\)O can be further promoted by prolonging the plasma exposure time.

Both plasma-assisted and thermal ALD of Li\(_2\)CO\(_3\) allow for conformal coating of high aspect ratio substrates as can be important for future Li-ion batteries. To the best of our knowledge this paper provides the first proper conductivity measurement of Li\(_2\)CO\(_3\) ALD films. An ion conductivity in the order of \( 10^{-10} \) S cm\(^{-1}\) was obtained for both plasma and thermal ALD after normalizing the fitted conductivity values to the ratio of the different effective surface areas. Studies are ongoing to characterize the electrochemical properties of the Li\(_2\)CO\(_3\) films in more depth.

**Conflicts of interest**

There are no conflicts to declare.

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**References**